

TOSHIBA Transistor Silicon PNP Triple Diffused Type (Darlington Power)

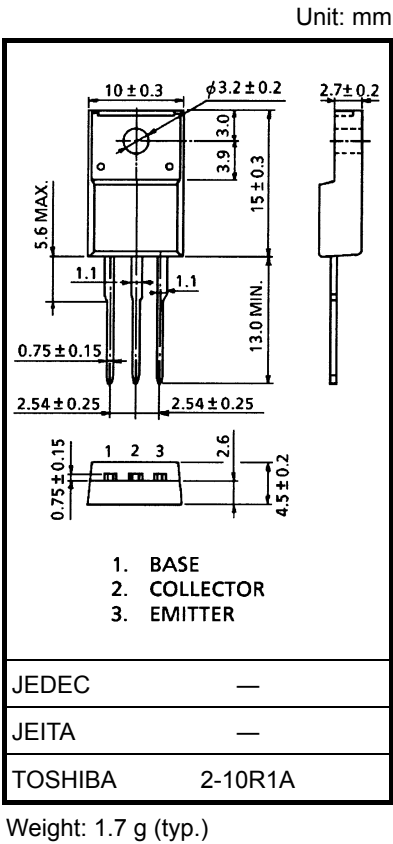
2SB1020A

High-Power Switching Applications
Hammer Drive, Pulse Motor Drive Applications

- High DC current gain: $h_{FE} = 2000$ (min) ($V_{CE} = -3\text{ V}$, $I_C = -3\text{ A}$)
- Low saturation voltage: $V_{CE(sat)} = -1.5\text{ V}$ (max) ($I_C = -3\text{ A}$)
- Complementary to 2SD1415A

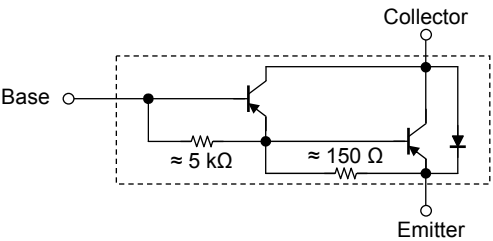
Absolute Maximum Ratings ($T_c = 25^\circ\text{C}$)

Characteristics		Symbol	Rating	Unit
Collector-base voltage		V_{CBO}	-100	V
Collector-emitter voltage		V_{CEO}	-100	V
Emitter-base voltage		V_{EBO}	-5	V
Collector current	DC	I_C	-7	A
	Pulse	I_{CP}	-10	
Base current		I_B	-0.7	A
Collector power dissipation	$T_a = 25^\circ\text{C}$	P_C	2.0	W
	$T_c = 25^\circ\text{C}$		30	
Junction temperature		T_j	150	$^\circ\text{C}$
Storage temperature range		T_{stg}	-55 to 150	$^\circ\text{C}$

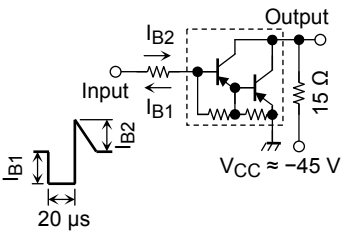


Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

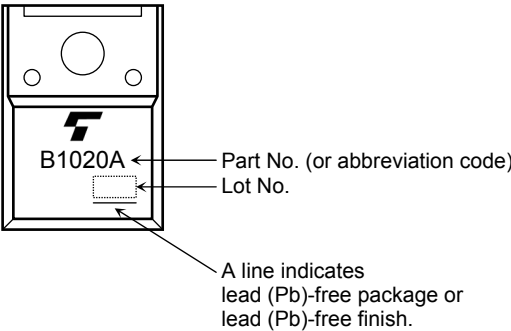
Equivalent Circuit

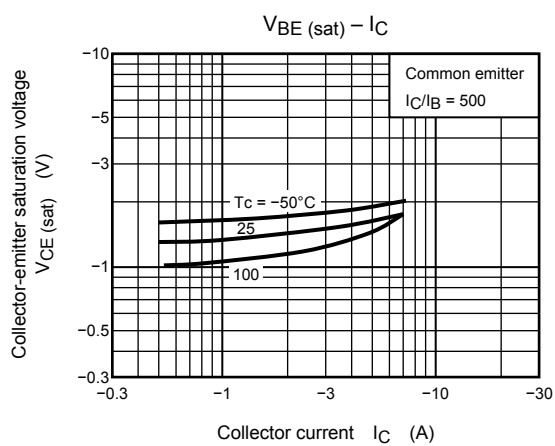
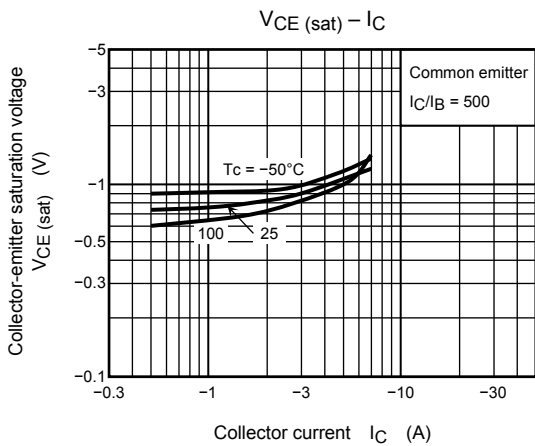
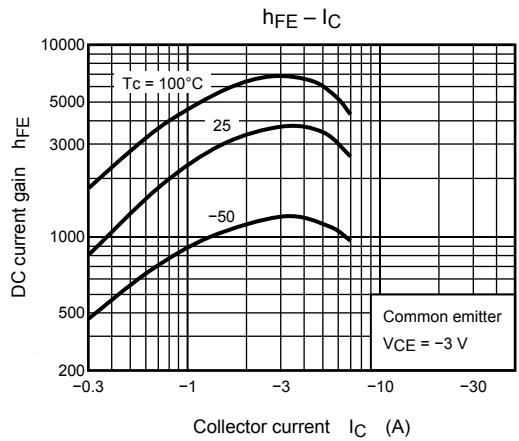
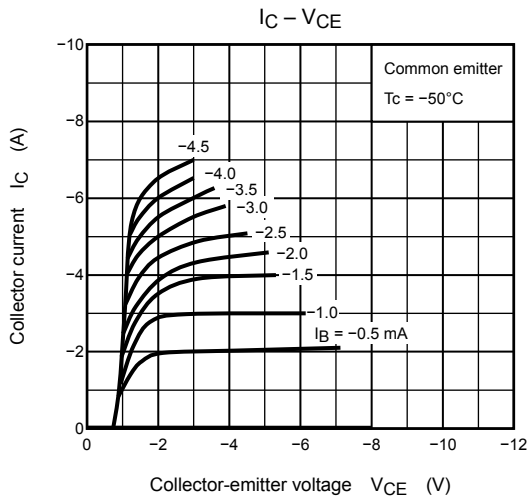
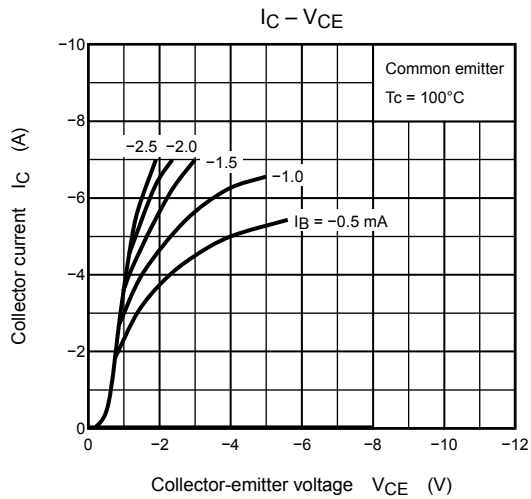
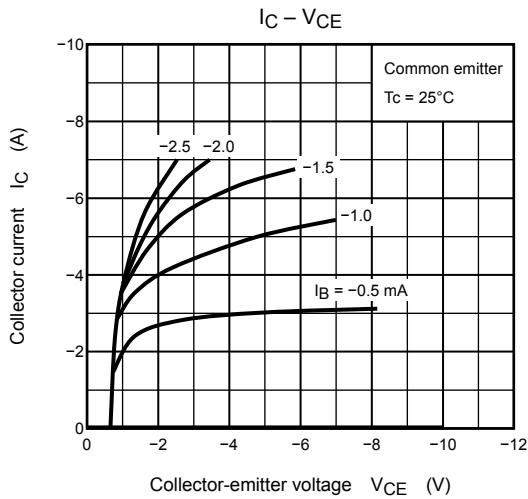


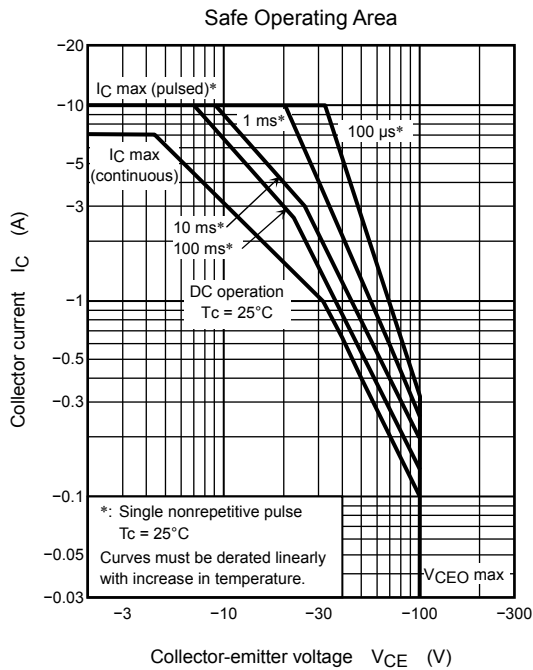
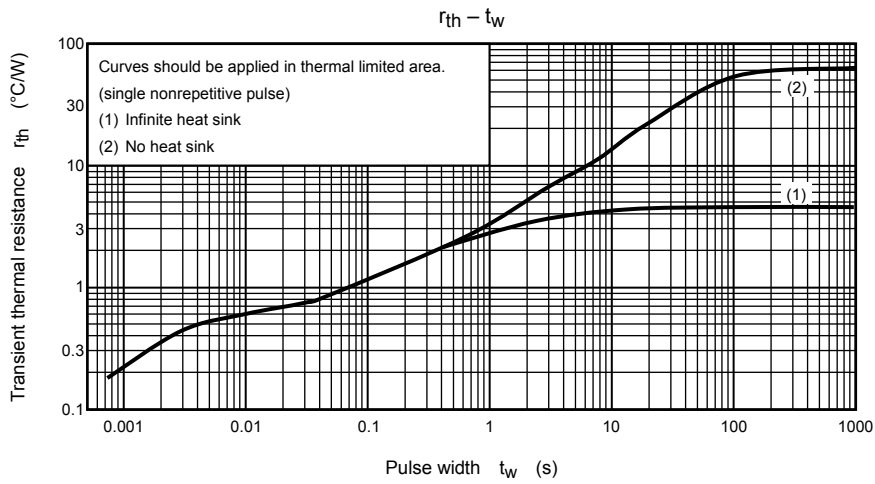
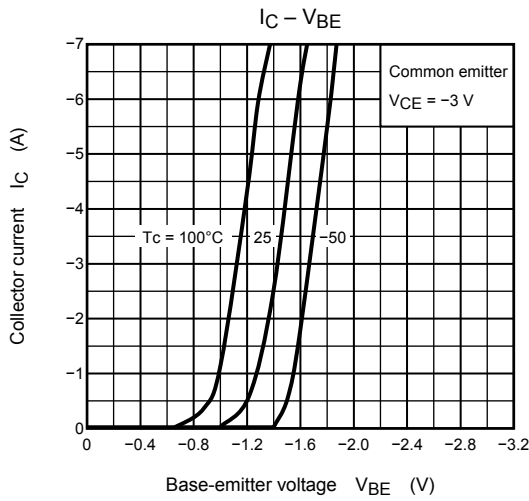
Electrical Characteristics (Tc = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		I_{CBO}	$V_{CB} = -100\text{ V}, I_E = 0$	—	—	-100	μA
Emitter cut-off current		I_{EBO}	$V_{EB} = -5\text{ V}, I_C = 0$	—	—	-4.0	mA
Collector-emitter breakdown voltage		$V_{(BR)\text{ CEO}}$	$I_C = -50\text{ mA}, I_B = 0$	-100	—	—	V
DC current gain		$h_{FE}\text{ (1)}$	$V_{CE} = -3\text{ V}, I_C = -3\text{ A}$	2000	—	15000	
		$h_{FE}\text{ (2)}$	$V_{CE} = -3\text{ V}, I_C = -7\text{ A}$	1000	—	—	
Collector-emitter saturation voltage		$V_{CE\text{ (sat) (1)}}$	$I_C = -3\text{ A}, I_B = -6\text{ mA}$	—	-0.95	-1.5	V
		$V_{CE\text{ (sat) (2)}}$	$I_C = -7\text{ A}, I_B = -14\text{ mA}$	—	-1.3	-2.0	
Base-emitter saturation voltage		$V_{BE\text{ (sat)}}$	$I_C = -3\text{ A}, I_B = -6\text{ mA}$	—	-1.55	-2.5	V
Switching time	Turn-on time	t_{on}	 $-I_{B1} = I_{B2} = 6\text{ mA}, \text{duty cycle} \leq 1\%$	—	0.8	—	μs
	Storage time	t_{stg}		—	2.0	—	
	Fall time	t_f		—	2.5	—	

Marking







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20070701-EN

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